Se	Search Notes		

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/770,386	BESSETTE ET AL.	
ĺ	Examiner	Art Unit	_
	Patricia Leith	1655	

	SEAR	CHED	
Class	Subclass	Date	Examiner
424	725	8/17/2005	PL
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INTERFERENCE SEARCHED		
Subclass	Date	Examiner
725	8/17/2005	PL
	Subclass	Subclass Date

SEARCH (INCLUDING SEA	I NOTES RCH STRATEGY)
	DATE	EXMR
T: Interference search & Inv e search	ventor 8/17/2005	PL